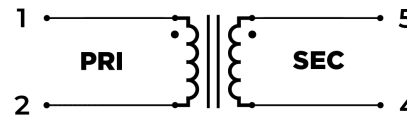


TEST CONDITIONS

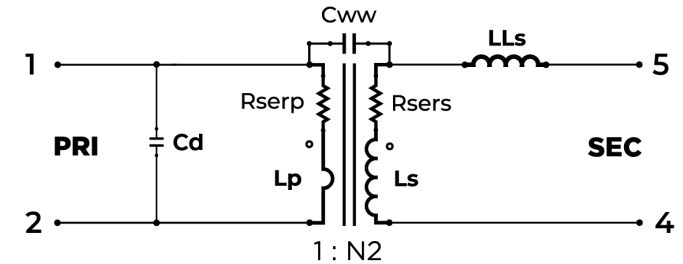
Inductance (L): 10 kHz, 1 V_{RMS}, Series
Leakage Inductance (LLs): 100 kHz, 0.1 V_{RMS}, Series
Interwinding Capacitance (Cww): 100 kHz, 0.1 V_{RMS}
Series Resistance (Rser): Measured at 25 °C
Cd: Measured by HP4194A equivalent A on secondary

EQUIPMENTS: 4194A, 4285A, 4284A, HOIKI 3541

SCHEMATIC SYMBOL



EQUIVALENT CIRCUIT



Part Number	Lp (1-2)	Ls (5-4)	Rserp (1-2)	Rsers (5-4)	Cd	Cww (1-2) - (5-4)	S.R.F (5-4)	LLs (5-4) Shorted (1-2)	Turn Ratio
	<i>uH, Typ.</i>	<i>mH, Typ.</i>	<i>mΩ, Typ.</i>	<i>Ω, Typ.</i>	<i>pF, Typ.</i>	<i>pF, Typ.</i>	<i>MHz, Typ.</i>	<i>uH, Typ.</i>	<i>1-2 : 5-4</i>
CT11-050	1.33	3.75	0.400	0.257	7.06	2.10	1.008	70.2	1 : 50
CT11-070	1.29	6.97	0.396	0.569	6.74	2.64	0.752	133.7	1 : 70
CT11-100	1.39	14.63	0.397	1.019	6.96	2.46	0.511	276.3	1 : 100
CT11-125	1.37	21.81	0.396	1.646	6.84	2.62	0.424	454.7	1 : 125
CT11-200	1.57	56.09	0.400	4.202	7.50	2.84	0.254	1127.0	1 : 200